



MS ISO/IEC 17025

Certificate of Accreditation

No: SAMM 088

Valid until: 14 September 2017

This is to certify that

**SIRIM STANDARDS TECHNOLOGY SDN. BHD.
SHAH ALAM, SELANGOR
MALAYSIA**

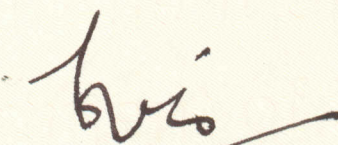
(FIELDS OF CALIBRATION: ELECTRICAL, TEMPERATURE, MASS,
DIMENSIONAL, FORCE, PRESSURE, TORQUE, VOLUMETRIC &
HYDROMETER)

has been granted accreditation in respect of the scope of accreditation described in the SCHEDULE attached, subject to the terms and conditions governing the *Skim Akreditasi Makmal Malaysia (SAMM)*, the Laboratory Accreditation Scheme of Malaysia.

"This laboratory is accredited in accordance with the recognised International Standard ISO/IEC 17025:2005. This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer joint ISO-ILAC-IAF Communiqué dated January 2009)".

Issuance of this certificate is governed by Section 16 Subsection (2) and (3) of Standards of Malaysia Act 1996, (Act 549).




(FADILAH BAHARIN)
Director General
Department of Standards Malaysia

Date of issue: 30 September 2014

Schedule

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Valid until: 14 September 2017



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LABORATORY LOCATION:
(PERMANENT LABORATORY)

SIRIM STANDARDS TECHNOLOGY SDN. BHD.
(Company No.: 292201-P)
LOT 12, 18 & 20, JALAN BEREMBAN 15/12
SEKSYEN 15
40200 SHAH ALAM, SELANGOR
MALAYSIA

This laboratory accredited under *Skim Akreditasi Makmal Malaysia* (SAMM) meets the requirements of MS ISO/IEC 17025:2005 'General requirements for competence of testing and calibration laboratories'. This Malaysian Standards is identical with ISO/IEC 17025:2005 published by the International Organization for Standardization (ISO).

*** The expanded uncertainties are based on an estimated confidence probability of approximately 95% and have a coverage factor of $k=2$ unless stated otherwise.**

FIELD OF CALIBRATION: ELECTRICAL

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument DC VOLTAGE	± 220 mV Range $\pm$ (0 mV to 220 mV) ± 2.2 V Range $\pm$ (0 V to 2.2 V) ± 11 V Range $\pm$ (0 V to 11 V) ± 22 V Range $\pm$ (0 V to 22 V) ± 220 V Range $\pm$ (0 V to 220 V) ± 1100 V Range $\pm$ (100 V to 1100 V)	$9 \mu\text{V/V} + 0.8 \mu\text{V}$ $8 \mu\text{V/V} + 1.2 \mu\text{V}$ $8 \mu\text{V/V} + 4 \mu\text{V}$ $8 \mu\text{V/V} + 8 \mu\text{V}$ $9 \mu\text{V/V} + 0.1 \text{ mV}$ $11 \mu\text{V/V} + 0.6 \text{ mV}$	Fluke 5700A
AC VOLTAGE	<u>2.2 mV to 220 V</u> (See Matrix A)	(See Matrix A)	Fluke 5700A

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue AC VOLTAGE	<u>1100 V Range (110 V to 1100 V)</u> 50 Hz to 1 kHz	90 μ V/V + 4 mV	Fluke 5700A
	<u>800 V to 1050 V</u> 1 kHz to 3 kHz 3 kHz to 10 kHz 10 kHz to 20 kHz	0.8 mV/V + 0.13 V 0.8 mV/V + 0.21 V 1.2 mV/V + 0.32 V	Wavetek 9100
DC CURRENT	$\pm 220 \mu$ A Range $\pm$ (0 mA to 220 μ A)	60 μ A/A + 10 nA	Fluke 5700A
	± 2.2 mA Range $\pm$ (0 mA to 2.2 mA)	60 μ A/A + 10 nA	
	± 22 mA Range $\pm$ (0 mA to 22 mA)	60 μ A/A + 0.1 μ A	
	± 220 mA Range $\pm$ (0 mA to 220 mA)	70 μ A/A + 1 μ A	
	± 2.2 A Range $\pm$ (0 A to 2.2 A)	95 μ A/A + 30 μ A	Wavetek 9100
	± 3.2 A Range $\pm$ (0.32 A to 3.2 A)	0.6 mA/A + 0.12 mA	
	± 10.5 A Range $\pm$ (3.2 A to 10.5 A)	0.55 mA/A + 0.94 mA	
	± 20 A Range $\pm$ (10.5 A to 20 A)	0.55 mA/A + 4.5 mA	
	± 100 A Range $\pm$ (20 A to 100 A)	0.45 mA/A + 20 mA	California 3213K

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1. Measuring Instrument Continue AC CURRENT	<u>9 μA to 2.2 A</u> (See Matrix B)	(See Matrix B)	Fluke 5700A
	<u>0.32 A to 3.2 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz <u>3.2 A to 10.5 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz <u>10.5 A to 20 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz	1 mA/A + 0.48 mA 2.5 mA/A + 2.6 mA 2 mA/A + 3 mA 5 mA/A + 10 mA 2 mA/A + 6.9 mA 5 mA/A + 23 mA	Wavetek 9100
	<u>20 A to 100 A</u> 10 Hz to 1 kHz 1 kHz to 10 kHz	2.5 mA/A + 0.03 A 5 mA/A + 0.05 A	California Instruments CA 3213K
	<u>3 mA to 3A</u> At Time interval up to 5 s At Time interval <190 ms	0.14 mA/A 0.3 mA/A	For RCD Tester Calibrator (using Transmille 3200)
CAPACITANCE	(See Matrix C)	(See Matrix C)	Wavetek 9100
Fixed Value	<u>20 Hz to 1 MHz</u> 1 pF, 10 pF, 100 pF, 1000 pF, 0.01 μ F, 0.1 μ F and 1.0 μ F	1 mF/F	HP 1600A series
INDUCTANCE Fixed Value	<u>100 μH @ 1 kHz</u> <u>(1, 10, 100) mH @ 1 kHz</u> <u>1H @ 1 kHz</u>	2.5 mH/H 1 mH/H 1 mH/H	Ando RS-100 series

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Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue RESISTANCE Fixed Value	1 m Ω 10 m Ω 100 m Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 k Ω 1.9 k Ω 10 k Ω 19 k Ω 100 k Ω 190 k Ω 1 M Ω 1.9 M Ω 10 M Ω 19 M Ω	0.2 m Ω/Ω 0.1 m Ω/Ω 0.02 m Ω/Ω 5 $\mu\Omega/\Omega$ 0.11 m Ω/Ω 5 $\mu\Omega/\Omega$ 31 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 0.02 m Ω/Ω 5 $\mu\Omega/\Omega$ 15 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 15 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 24 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 0.05 m Ω/Ω	Fluke 5700A & Fluke 742A Series
	100 M Ω 1 G Ω 10 G Ω 100 G Ω 1 T Ω	0.13 m Ω/Ω 5 $\mu\Omega/\Omega$ 0.02 Ω/Ω 0.05 Ω/Ω 0.05 Ω/Ω	Fluke 5700A & Takeda Riken TR45
POWER/ ENERGY (DC)	1 kW to 20 kW 0.1 W to 1 kW	0.7 mW/W 0.22 mW/W	Fluke 5520A

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue TIME	1 s to 24 Hrs	0.06 μ s/s + 0.021 s	Agilent 33250A & Universal Counter HP 53132A
	20 ms to 5 s	0.7 ms	For RCD Tester Calibrator (using Transmile 3200)
Residual Current Duration	10 ms to 5 s	0.4 ms	
RPM Measuring Instruments (Non Contact)	60 to 5999 rpm 6000 to 29999 rpm 30000 to 59999 rpm 60000 to 99999 rpm	0.07 rpm 7 rpm 36 rpm 70 rpm	In-House method, ESF/0303
HIGH VOLTAGE METER DC Voltage AC Voltage @ (50/60) Hz	0.5 kV to 10 kV	5 mV/V	TDV 20 ADS & TOS 5101
		8 mV/V	
CLAMP METER DC Current 10 – Turn Coil 50 – Turn Coil	$\pm$ 3.2 A to 32 A $\pm$ 32 A to 105 A $\pm$ 105 A to 200 A	0.06 mA/A + 1.18 mA 0.55 mA/A + 9.4 mA 0.55 mA/A + 45 mA	Wavetek 9100 c/w Current Coil
	$\pm$ 16 A to 160 A $\pm$ 160 A to 525 A $\pm$ 525 A to 1000 A	0.6 mA/A + 5.9 mA 0.55 mA/A + 47 mA 0.55 mA/A + 0.23 A	
AC Current <u>10 – Turn Coil</u>	<u>3.2 A to 32 A</u> 10 Hz to 100 Hz 100 Hz to 440 Hz 32 A to 200 A 10 Hz to 100 Hz 100 Hz to 440 Hz	2 mA/A + 5.5 mA 7.8 mA/A + 27 mA 2.1 mA/A + 90 mA 6.7 mA/A + 0.25 A	

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1. Measuring Instrument Continue CLAMP METER <u>50 – Turn Coil</u>	<u>16 A to 160 A</u> 10 Hz to 100 Hz <u>160 A to 1000 A</u> 10 Hz to 100 Hz	2 mA/A + 28 mA 2.1 mA/A + 0.45 A	Wavetek 9100 c/w Current Coil
INSULATION TESTER	(1 k Ω to 10 k Ω) @ 10 V (10 k Ω to 100 k Ω) @ 50 V (0.1 M Ω to 1 M Ω) @ 150 V (1 M Ω to 10 M Ω) @ 300 V (10 M Ω to 100 M Ω) @ 500 V (0.1 G Ω to 1 G Ω) @ 1000 V (1 G Ω to 10 G Ω) @ 5000 V (10 G Ω to 100 G Ω) @ 5000 V (100 G Ω to 600 G Ω) @ 5000	0.5 m Ω/Ω 1 m Ω/Ω 10 m Ω/Ω 50 m Ω/Ω 0.1 Ω/Ω 50 m Ω/Ω	Tinsley 4720
OSCILLOSCOPE Vertical Deflection DC Signal	0 V to $\pm$ 6.6 V (50 Ω Load) 0 V to $\pm$ 130 V (1 M Ω Load)	2.5 mV/V + 0.04 mV 0.5 mV/V + 0.04 mV	Fluke 5500A SC600
Vertical Deflection Square Wave Signal	$\pm$ 1 mVp-p to $\pm$ 6.6 Vp-p (50 Ω Load) $\pm$ 1 mVp-p to $\pm$ 130 Vp-p (1 M Ω Load)	2.5 mVp-p/Vp-p + 0.04mVp-p 1 mVp-p/Vp-p + 0.04 mVp-p	
Horizontal Deflection Time Markers (50 Ω Load)	2 ns/div to 20 ms/div 50 ms/div to 5 s/div	2.5 μ s/s (25+(Output x 1000)) μ s/s	
Risetime	$\leq$ 300 ps	+0 ns / -0.1 ns	
Bandwidth Frequency	50 kHz to 600 MHz	2.5 μ Hz/Hz	
	600 MHz to 40 GHz (+11 dBm to -135 dBm)	7 nHz/Hz	Agilent E8257D Reference to Pendulum GPS-12R Disciplined by GPS

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1. Measuring Instrument Continue OSCILLOSCOPE Bandwidth Amplitude	50 kHz to 600 MHz	0.03 Vp-p	Fluke 5500A SC600
Frequency	600 MHz to 40 GHz (+11 dBm to -135 dBm)	0.92 dBm	Agilent E8257D
	1 μ Hz to 80 MHz (10 mVpp to 10 Vpp) 10 kHz to 40 GHz (+11 dBm to -135dBm)	36 nHz/Hz 7 nHz/Hz	(Agilent 33250A, ifR2042 or Agilent E8257D) Reference to Pendulum GPS-12R Disciplined by GPS
	10 mVp-p to 10 Vp-p (1 μ Hz to 80 MHz, Into 50 Ω)	10 mVpp/Vpp + 1 mVpp	Agilent 33250A
Amplitude	+13 dBm to -144dBm (10 kHz to 5.4 GHz)	0.58 dBm	ifR2042
	+11 dBm to -135dBm (250 kHz to 40 GHz)	0.92 dBm	Agilent E8257D
	Sine Wave Relative to 1 kHz (Auto range On)	0.4 dBm	Agilent 33250A
Flatness			

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SCOPE OF ACCREDITATION:

Matrix A

AC Voltage Measurement

Range		Frequency			
		Hz		kHz	
		10 to 20	20 to 40	0.04 to 20	20 to 50
2.2 mV	0.22 mV to 2.2 mV	0.6 + 0.005	0.24 + 0.005	0.12 + 0.005	0.41 + 0.005
22 mV	2.2 mV to 22 mV	0.6 + 0.006	0.24 + 0.006	0.12 + 0.006	0.41 + 0.006
220 mV	22 mV to 220 mV	0.6 + 0.016	0.24 + 0.01	0.11 + 0.01	0.36 + 0.01
2.2 V	0.22 V to 2.2 V	0.6 + 0.1	0.18 + 0.03	0.085 + 0.007	0.14 + 0.02
22 V	2.2 V to 22 V	0.6 + 1	0.18 + 0.3	0.085 + 0.07	0.14 + 0.2
220 V	22 V to 220 V	0.6 + 10	0.18 + 3	0.09 + 1	0.25 + 4

Range		Frequency			
		MHz			
		0.05 to 0.1	0.1 to 0.3	0.3 to 0.5	0.5 to 1
2.2 mV	0.22 mV to 2.2 mV	0.95 + 0.008	1.3 + 0.015	1.8 + 0.03	3.6 + 0.03
22 mV	2.2 mV to 22 mV	0.95 + 0.008	1.3 + 0.015	1.8 + 0.03	3.6 + 0.03
220 mV	22 mV to 220 mV	0.9 + 0.03	1.1 + 0.03	1.8 + 0.04	3.6 + 0.1
2.2 V	0.22 V to 2.2 V	0.28 + 0.08	0.48 + 0.15	1.2 + 0.4	2.4 + 1
22 V	2.2 V to 22 V	0.28 + 0.4	0.6 + 1.7	1.4 + 5	3 + 9
220 V	22 V to 220 V	0.6 + 10	1.6 + 110	5.4 + 110	13 + 220

The expanded uncertainties given in this table are expressed in mV/V + mV

Matrix B

AC Current Measurement

Range	Frequency (kHz)				
	0.01 to 0.02	0.02 to 0.04	0.04 to 1	1 to 5	5 to 10
9 μ A to 220 μ A	0.8 + 0.03	0.42 + 0.025	0.16 + 0.02	0.7 + 0.05	1.8 + 0.1
0.22 mA to 2.2 mA	0.8 + 0.05	0.42 + 0.04	0.16 + 0.04	0.7 + 0.5	1.8 + 1
2.2 mA to 22 mA	0.8 + 0.5	0.42 + 0.4	0.16 + 0.4	0.7 + 10	1.8 + 0.01
22 mA to 220 mA	0.8 + 5	0.42 + 4	0.18 + 4	0.7 + 50	1.8 + 100
0.22 A to 2.2 A	-	-	0.75 + 40	0.85 + 100	10 + 200

The expanded uncertainties given in this table are expressed in mA/A + μ A

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Matrix C

Capacitance Measurement

Range	Frequency	
	≤ 350 Hz	350 Hz to 1.5 kHz
0.5 nF to 4 nF	3 mF/F + 15 pF	6 mF/F + 0.03 nF
4 nF to 40 nF	3 mF/F + 30 pF	6 mF/F + 0.06 nF
40 nF to 400 nF	3 mF/F + 0.16 nF	6 mF/F + 0.32 nF
400 nF to 4 μ F	4 mF/F + 1.6 nF	8 mF/F + 3.2 nF
4 μ F to 40 μ F	5 mF/F + 16 nF	10 mF/F + 32 nF
40 μ F to 400 μ F	5 mF/F + 0.16 μ F	10 mF/F + 0.32 μ F
400 μ F to 4 mF	5 mF/F + 1.6 μ F	10 mF/F + 3.2 μ F
4 mF to 40 mF	10 mF/F + 0.06 mF	20 mF/F + 0.12 mF

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument DC VOLTAGE	± 100 mV Range $\pm (100 \mu\text{V to } 120 \text{ mV})$	$5 \mu\text{V/V} + 0.3 \mu\text{V}$	HP 3458A Opt. 002
	± 1 V Range $\pm (100 \text{ mV to } 1.2 \text{ V})$	$4 \mu\text{V/V} + 0.3 \mu\text{V}$	
	± 10 V Range $\pm (1 \text{ V to } 12 \text{ V})$	$4 \mu\text{V/V} + 0.5 \mu\text{V}$	
	± 100 V Range $\pm (10 \text{ V to } 120 \text{ V})$	$6 \mu\text{V/V} + 0.03 \text{ mV}$	
	± 1000 V Range $\pm (100 \text{ V to } 1050 \text{ V})$	$6 \mu\text{V/V} + 0.1 \text{ mV}$	

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue DC VOLTAGE	100 mV @ ± 100 % Band Span $\pm$ (85 mV to 115 mV)	4 μ V/V	Wavetek 4950
	1 V @ ± 100 % Band Span $\pm$ (0.9 V to 1.1 V)	2.2 μ V/V	
	10 V @ ± 100 % Band Span $\pm$ (9 V to 11 V)	1.4 μ V/V	
	10 V @ ± 190 % Band Span $\pm$ (18 V to 19.5 V)	1.8 μ V/V	
	100 V @ ± 100 % Band Span $\pm$ (90 V to 110 V)	2 μ V/V	
	1000 V @ ± 100 % Band Span $\pm$ (900 V to 1100 V)	2 μ V/V	
AC VOLTAGE	1 mV to 1000V (See Matrix D)	(See Matrix D)	Wavetek 4950
	2.2 mV to 1000V (See Matrix E)	(See Matrix E)	Fluke 5790A
	10 mV to 700V (See Matrix F)	(See Matrix F)	HP 3458A Opt. 002
DC CURRENT	110 μ A @ ± 100 % Band Span $\pm$ (90 μ A to 110 μ A)	21 μ A/A	Wavetek 4950
	1 mA @ ± 100 % Band Span $\pm$ (0.9 mA to 1.1 mA)	11 μ A/A	
	10 mA @ ± 100 % Band Span $\pm$ (9 mA to 11 mA)	11 μ A/A	
	100 mA @ ± 100 % Band Span $\pm$ (90 mA to 110 mA)	15 μ A/A	
	1 A @ ± 100 % Band Span $\pm$ (0.9 A to 1.1 A)	25 μ A/A	

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Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue DC CURRENT	$\pm$ (1 nA to 100 nA)	30 μ A/A + 0.04 nA	HP 3458A Opt. 002
	$\pm$ (100 nA to 1 μ A)	20 μ A/A + 0.04 nA	
	$\pm$ (1 μ A to 10 μ A)	20 μ A/A + 0.1 nA	
	$\pm$ (10 μ A to 100 μ A)	20 μ A/A + 0.8 nA	
	$\pm$ (100 μ A to 1 mA)	20 μ A/A + 5 nA	
	$\pm$ (1 mA to 10 mA)	20 μ A/A + 0.05 μ A	
	$\pm$ (10 mA to 100 mA)	35 μ A/A + 0.5 μ A	
	$\pm$ (100 mA to 1 A)	0.11 mA/A + 0.01 mA	
	$\pm$ (1 pA to 20 pA)	0.01 A/A + 3 nA	Keithley 6517/ Agilent 4339A
	$\pm$ (20 pA to 200 pA)	0.01 A/A + 5 nA	
	$\pm$ (200 pA to 2 nA)	2 mA/A + 0.3 μ A	Wavetek 4950 & 4953
	10 A @ $\pm$ 100 % Band Span $\pm$ (9 A to 11 A)	55 μ A/A	
	$\pm$ (1 A to 10 A)	5.1 mA	
	$\pm$ (10 A to 100 A)	0.05 A	
AC CURRENT	5 μ A to 1 A (See Matrix G)	(See Matrix G)	HP 3458A
	90 μ A to 1 A (See Matrix H)	(See Matrix H)	Wavetek 4950
	10 A @ 100 % Band Span (See Matrix I)	(See Matrix I)	Wavetek 4950 & 4953

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue RESISTANCE	<u>1 kΩ</u> 30 % Band Span (0.2 k Ω to 0.4 k Ω), 100 % Band Span (0.9 k Ω to 1.1 k Ω), 190 % Band Span (1.8 k Ω to 1.95 k Ω)	3 $\mu\Omega/\Omega$	Wavetek 4950
	<u>10 kΩ</u> 30 % Band Span (2 k Ω to 4 k Ω), 100 % Band Span (9 k Ω to 11 k Ω), 190 % Band Span (18 k Ω to 19.5 k Ω)	3 $\mu\Omega/\Omega$	
	<u>100 kΩ</u> 30 % Band Span (20 k Ω to 40 k Ω), 100 % Band Span 90 k Ω to 110 k Ω) & 190 % Band Span (180 k Ω to 195 k Ω)	6 $\mu\Omega/\Omega$	
	<u>1 MΩ</u> 30 % Band Span (0.2 M Ω to 0.4 M Ω), 100 % Band Span (0.9 M Ω to 1.1 M Ω) & 190 % Band Span (1.8 M Ω to 1.95 M Ω)	11 $\mu\Omega/\Omega$	
	<u>10 MΩ</u> 30 % Band Span (2 M Ω to 4 M Ω), 100 % Band Span (9 M Ω to 11 M Ω) & 190 % Band Span (18 M Ω to 19.5 M Ω)	21 $\mu\Omega/\Omega$	

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Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue RESISTANCE	<u>100 MΩ</u> 30 % Band Span (20 M Ω to 40 M Ω), 100 % Band Span (90 M Ω to 110 M Ω)	83 $\mu\Omega/\Omega$	Wavetek 4950
CAPACITANCE	1 pF to 1 mF @ (10 Hz to 1 MHz)	0.5 mF/F	HP 4284A
INDUCTANCE	1 μ H to 10 H @ (10 Hz to 1 MHz)	0.5 mH/H	
FREQUENCY	1 Hz to 5 GHz	0.89 pHz/Hz	HP53132A Reference to Pendulum GPS- 12R Disciplined by GPS
AMPLITUDE/ LEVEL	-20 dBm to +30 dBm (100 kHz to 2.6 GHz)	0.04 dBm	HP 8902 with 11722A
RF FREQUENCY	5 GHz to 26.5 GHz	0.89 Hz/Hz	HP8563E Reference to Pendulum GPS- 12R Disciplined by GPS
RF AMPLITUDE/ LEVEL	-30 dB to +30 dB (2.6 GHz to 18 GHz)	0.27 dBm	Agilent E4418B with HP 8481A
	-120 dB to +30 dB (30 Hz to 26.5 GHz)	1 dBm	HP8563E
TUNED RF LEVEL	-127 dB to 0 dB (2.5 MHz to 1.3 GHz)	0.07 dBm	HP 8902 with 11722A

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue MODULATION Related Signal: Amplitude Modulation (AM) AM Depth: 5% to 99%	Carrier Frequency 150 kHz to 10 MHz Modulation Frequency 50 Hz to 10 kHz	0.17 %	HP 8902 with 11722A
	Carrier Frequency 150 kHz to 1300 MHz Modulation Frequency 20 Hz to 10 kHz	0.19 %	
	Carrier Frequency 10 MHz to 1300 MHz Modulation Frequency 50 Hz to 100 kHz	0.13 %	
Frequency Modulation (FM) FM Deviation: ≤ 40 kHz peak	Carrier Frequency 150 kHz to 10 MHz Modulation Frequency 20 Hz to 10 kHz	0.13 kHz	
FM Deviation: ≤ 400 kHz peak	Carrier Frequency 10 MHz to 1300 MHz Modulation Frequency 50 Hz to 100 kHz	0.03 kHz	
	Carrier Frequency 10 MHz to 1300 MHz Modulation Frequency 100 kHz to 200 kHz	0.32 kHz	
Phase Modulation (Φ M) Φ M Deviation: ≤ 40 Radians peak	Carrier Frequency 150 kHz to 10 MHz Modulation Frequency 200 Hz to 10 kHz	0.15 Radians	
Φ M Deviation: ≤ 400 Radians peak	Carrier Frequency 10 MHz to 1.3 GHz Modulation Frequency 200 Hz to 20 kHz	0.14 Radians	

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue DISTORTION Related Signal: Audio Distortion (-99 to 0) dB	Fundamental Frequency 20 Hz to 20 kHz Fundamental Frequency 20 kHz to 100 kHz	1 dB 2 dB	HP 8903B
RPM Non Contact Measurement Contact Measurement	10 to 29 rpm 30 to 59 rpm 60 to 99 rpm 100 to 299 rpm 300 to 599 rpm 600 to 999 rpm 1000 to 2999 rpm 3000 to 5999 rpm 6000 to 9999 rpm 10000 to 29999 rpm 30000 to 59999 rpm 60000 to 99999 rpm 20 to 29 rpm 30 to 59 rpm 60 to 99 rpm 100 to 299 rpm 300 to 599 rpm 600 to 999 rpm 1000 to 2999 rpm 3000 to 5999 rpm 6000 to 9999 rpm 10000 to 12999 rpm 13000 to 25999 rpm 26000 to 29999 rpm	0.014 rpm 0.036 rpm 0.07 rpm 0.14 rpm 0.37 rpm 0.7 rpm 1.4 rpm 3.6 rpm 7 rpm 14 rpm 36 rpm 70 rpm 0.011 rpm 0.016 rpm 0.029 rpm 0.07 rpm 0.16 rpm 0.29 rpm 0.7 rpm 1.6 rpm 2.9 rpm 7 rpm 8 rpm 14 rpm	In-House method, ESF/0303
High Voltage Tester DC VOLTAGE	0 kV to 9.99 kV 10 kV to <20 kV 20 kV to 35 kV >35 kV to 40 kV	5 mV/V + 2 V 20 mV/V 10 mV/V 20 mV/V	TDV 20 ADS Fluke 80K-40

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FIELD OF CALIBRATION: ELECTRICAL

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue AC VOLTAGE	(0 kV to 9.99 kV) @ 50/60 Hz (10 kV to 20 kV) @ 50/60 Hz (20 kV to 28 kV) @ 50/60 Hz	7 mV/V + 3 V 7 mV/V + 30 V 50 mV/V	TDV 20 ADS Fluke 80K-40

Matrix D
AC Voltage Generation (Wavetek 4950)

Range		Frequency Band				
		9 to 11 Hz	18 to 22 Hz	27 to 33 Hz	36 to 44 Hz	46.3 to 63.7 Hz
1 mV	0.85 to 1.15 mV	0.28 mV/V				
10 mV	8.5 to 11.5 mV	0.16 mV/V				
100 mV	85 mV to 115 mV	0.12 mV/V				
1 V	0.9 to 1.1 V	36 μ V/V			24 μ V/V	
10 V	9 to 11 V					
100 V	90 to 110 V	41 μ V/V			36 μ V/V	
1000 V	900 to 1100 V	μ				37 μ V/V

Range		Frequency Band					
		270 to 440 Hz	0.9 to 1.1 kHz	9 to 11 kHz	18 to 22 kHz	27 to 33 kHz	
1 mV	0.85 to 1.15 mV	0.26 mV/V		0.28 mV/V	0.29 mV/V	0.39 mV/V	
10 mV	8.5 to 11.5 mV	0.14 mV/V		0.16 mV/V	0.17 mV/V	0.24 mV/V	
100 mV	85 mV to 115 mV	89 μ V/V		0.12 mV/V	0.19 mV/V		
1 V	0.9 to 1.1 V	24 μ V/V					
10 V	9 to 11 V						26 μ V/V
	18 to 19.5 V	μ		μ	μ	μ	
100 V	90 to 110 V	26 μ V/V					29 μ V/V
1000 V	900 to 1100 V	37 μ V/V		42 μ V/V	47 μ V/V	74 μ V/V	

Range		Frequency Band (kHz)				
		45 to 55	90 to 110	180 to 220	270 to 330	450 to 550
1 mV	0.85 to 1.15 mV	0.39 mV/V	0.62 mV/V	μ	0.75 mV/V	0.77 mV/V
10 mV	8.5 to 11.5 mV	0.24 mV/V	0.4 mV/V		0.58 mV/V	0.61 mV/V
100 mV	85 mV to 115 mV	0.19 mV/V	0.36 mV/V		96 μ V/V	0.2 μ V/V
1 V	0.9 to 1.1 V	31 μ V/V	37 μ V/V		83 μ V/V	0.18 mV/V
10 V	9 to 11 V	26 μ V/V			0.24 mV/V	
100 V	90 to 110 V	35 μ V/V	64 μ V/V			
1000 V	600 to 800 V	0.11 mV/V	0.34 mV/V			

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SCOPE OF ACCREDITATION:

Matrix D

AC Voltage Generation Continue (Wavetek 4950)

Range		Frequency Band
		0.9 to 1.1 MHz
1 mV	0.85 to 1.15 mV	1.1 mV/V
10 mV	8.5 to 11.5 mV	0.95 mV/V
100 mV	85 mV to 115 mV	
1 V	0.9 to 1.1 V	0.56 mV/V
10 V	9 to 11 V	0.53 mV/V

Matrix E

AC Voltage Generation (Fluke 5790A)

Range		Frequency Band			
		10 to 20 Hz	20 to 40 Hz	40 Hz to 20 kHz	20 to 50 kHz
2.2 mV	0.6 to 2.2 mV	1.7 + 1.3	0.74 + 1.3	0.42 + 1.3	0.81 + 2
7 mV	1.9 to 7 mV	0.85 + 1.3	0.37 + 1.3	0.21 + 1.3	0.4 + 2
22 mV	8.5 to 11.5 mV	0.29 + 1.3	0.19 + 1.3	0.11 + 1.3	0.21 + 2
70 mV	19 to 70 mV	0.24 + 1.5	0.12 + 1.5	24 μ V/V + 1.5	0.13 + 2
220 mV	60 to 220 mV	0.21 + 1.5	85 μ V/V + 1.5	38 μ V/V + 1.5	69 μ V/V + 2
700 mV	190 to 700 mV		24 μ V/V + 1.5	33 μ V/V + 1.5	51 μ V/V + 2
2.2 V	0.6 to 2.2 V	0.2	66 μ V/V	24 μ V/V	46 μ V/V
7 V	1.9 to 7 V		67 μ V/V		48 μ V/V
22 V	6 to 22 V		68 μ V/V	27 μ V/V	57 μ V/V
70 V	19 to 70 V			32 μ V/V	
220 V	60 to 220 V		99 μ V/V	31 μ V/V	69 μ V/V
700 V	190 V to 700 V			41 μ V/V	0.13
1000 V	600 V to 1050 V			38 μ V/V	

Range		Frequency Band			
		50 to 100 kHz	100 to 300 kHz	300 to 500 kHz	500 kHz to 1 MHz
2.2 mV	0.6 to 2.2 mV	1.2 + 2.5	2.3 + 4	2.4 + 8	3.5 + 8
7 mV	1.9 to 7 mV	0.6 + 2.5	1.2 + 4	1.3 + 8	2.3 + 8
22 mV	8.5 to 11.5 mV	0.31 + 2.5	0.81 + 4	0.89 + 8	1.7 + 8
70 mV	19 to 70 mV	0.26 + 2.5	0.51 + 4	0.67 + 8	1.1 + 8
220 mV	60 to 220 mV	0.16 + 2.5	0.25 + 4	0.38 + 8	1 + 8
700 mV	190 to 700 mV	79 $\mu\text{V/V}$ + 2.5	0.18 + 4	0.3 + 8	0.96 + 8
2.2 V	0.6 to 2.2 V	71 $\mu\text{V/V}$	0.16	0.26	0.9
7 V	1.9 to 7 V	81 $\mu\text{V/V}$	0.19	0.4	1.2
22 V	6 to 22 V				
70 V	19 to 70 V	94 $\mu\text{V/V}$	0.2	0.41	
220 V	60 to 220 V	98 $\mu\text{V/V}$	0.21	0.5	
700 V	190 V to 700 V	0.5	μ		
1000 V	600 V to 1050 V				

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SCOPE OF ACCREDITATION:

Matrix F
AC Voltage Generation (HP 3458A)

Range		Frequency Band				
		1 to 40 Hz	0.1 to 1 MHz	1 to 4 MHz	4 to 8 MHz	8 to 10 MHz
10 mV	1 to 12 mV	0.3 + 3	12 + 5	70 + 7	0.2 V/V + 8	–

Range		Frequency Band				
		1 to 40 Hz	1 to 2 MHz	2 to 4 MHz	4 to 8 MHz	8 to 10 MHz
100 mV	10 to 120 mV	70 μ V/V + 4	15 + 10	40 + 70	40 + 80	0.15 V/V + 0.1 mV
1 V	0.1 V 1.2 V	70 μ V/V + 40	15 + 0.1 mV	40 + 0.7 mV	40 + 0.8 mV	0.15 V/V + 1 mV
10 V	1 to 12 V	70 μ V/V + 0.4 mV	15 + 1 mV	40 + 7 mV	40 + 8 mV	0.15 V/V + 10 mV

Range		Frequency Band	
		1 to 40 Hz	0.3 to 1 MHz
100 V	10 to 120 V	0.2 + 4 mV	15 + 10 mV
1000 V	100 to 700 V	0.4 + 40 mV	

The expanded uncertainties given in this table are expressed in mV/V + μ V unless otherwise stated.

Matrix G
AC Current Generation (HP 3458A)

Range		Frequency Band			
		10 to 20 Hz	20 to 45 Hz	45 to 100 Hz	100 Hz to 5 kHz
100 μ A	5 to 120 μ A	4 + 30 nA	1.5 + 30 nA	0.6 + 3 nA	
1 mA	0.05 to 1.2 mA	4 + 0.2	1.5 + 0.2	0.6 + 0.2	0.3 + 0.2
10 mA	0.5 to 12 mA	4 + 2	1.5 + 2	0.6 + 2	0.3 + 2
100 mA	5 to 120 mA	4 + 20	1.5 + 20	0.6 + 20	0.3 + 20
1 A	0.05 to 1.05 A	4 + 0.2 mA	1.6 + 0.2 mA	0.8 + 0.2 mA	1 + 0.2 mA

Range		Frequency Band		
		5 to 20 kHz	20 to 50 kHz	50 to 100 kHz
1 mA	0.05 to 1.2 mA	0.6 + 0.2	4 + 0.4	5.5 + 1.5
10 mA	0.5 to 12 mA	0.6 + 2	4 + 4	5.5 + 15
100 mA	5 to 120 mA	0.6 + 20	4 + 40	5.5 + 0.15 mA
1 A	0.05 to 1.05 A	3 + 0.2 mA	10 + 0.4 mA	

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SCOPE OF ACCREDITATION:

Matrix H

AC Current Generation (Wavetek 4950)

Range		Frequency Band			
		9 to 11 Hz	18 to 22 Hz	27 to 33 Hz	36 to 44 Hz
100 μ A	90 to 110 μ A	0.12		0.11	85 μ A/A
1 mA	0.9 to 1.1 mA			0.1	80 μ A/A
10 mA	9 to 11 mA	0.13		96 μ A/A	75 μ A/A
100 mA	90 to 110 mA				
1 A	0.9 to 1.1 A	0.16			0.11

Range		Frequency Band			
		46.25 to 63.75 Hz	270 to 440 Hz	0.9 to 1.1 kHz	4.5 to 5.5 kHz
100 μ A	90 to 110 μ A	85 μ A/A			0.13
1 mA	0.9 to 1.1 mA	80 μ A/A			0.12
10 mA	9 to 11 mA	75 μ A/A			
100 mA	90 to 110 mA				
1 A	0.9 to 1.1 A	0.11			0.21

Range		Frequency Band		
		9 to 11 kHz	18 to 22 kHz	27 to 33 kHz
100 μ A	90 to 110 μ A	0.3	0.33	0.4
1 mA	0.9 to 1.1 mA	0.26	0.28	0.35
10 mA	9 to 11 mA			
100 mA	90 to 110 mA			
1 A	0.9 to 1.1 A			

The expanded uncertainties given in this table are expressed in mA/A unless otherwise stated.

Matrix I

AC Current Generation (Wavetek 4950 & 4953)

Range		Frequency Band				
		9 to 11 Hz	18 to 22 Hz	27 to 33 Hz	36 to 44 Hz	46.25 to 63.75 Hz
10 A	9 to 11 A	0.24		0.23	0.21	0.2

Range		Frequency Band				
		270 to 440 Hz	0.9 to 1.1 kHz	4.5 to 5.5 kHz	9 to 11 kHz	18 to 22 kHz
10 A	9 to 11 A	0.2		0.26	0.34	1.2

The expanded uncertainties given in this table are expressed in mA/A.

Signatories:

1. Muhammed Fahimy Bin Ahmad Ta'adin
2. Mohamed Fikri Bin Mohd Nor
3. Syahrel Bin Shari

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument DC VOLTAGE	± 220 mV Range $\pm$ (0 mV to 220 mV) ± 2.2 V Range $\pm$ (0 V to 2.2 V) $+11$ V Range $\pm$ (0 V to 11 V) ± 22 V Range $\pm$ (0 V to 22 V) ± 220 V Range $\pm$ (0 V to 220 V) ± 1100 V Range $\pm$ (100 V to 1100 V)	$9 \mu\text{V/V} + 0.8 \mu\text{V}$ $8 \mu\text{V/V} + 1.2 \mu\text{V}$ $8 \mu\text{V/V} + 4 \mu\text{V}$ $8 \mu\text{V/V} + 8 \mu\text{V}$ $9 \mu\text{V/V} + 0.1 \text{ mV}$ $11 \mu\text{V/V} + 0.6 \text{ mV}$	Fluke 5700A
AC VOLTAGE	2.2 mV to 220 V (See Matrix A) 1100 V Range (110 V to 1100 V) 50 Hz to 1 kHz	(See Matrix A) $90 \mu\text{V/V} + 4 \text{ mV}$	Fluke 5700A
	<u>800 V to 1050 V</u> 1 kHz to 3 kHz 3 kHz to 10 kHz 10 kHz to 20 kHz	$0.8 \text{ mV/V} + 0.13 \text{ V}$ $0.8 \text{ mV/V} + 0.21 \text{ V}$ $1.2 \text{ mV/V} + 0.32 \text{ V}$	Wavetek 9100
DC CURRENT	± 100 A Range $\pm$ (20 A to 100 A)	$0.45 \text{ mA/A} + 20 \text{ mA}$	California 3213K

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue DC CURRENT	$\pm 220 \mu\text{A}$ Range $\pm (0 \text{ mA to } 220 \mu\text{A})$ $\pm 2.2 \text{ mA}$ Range $\pm (0 \text{ mA to } 2.2 \text{ mA})$ $\pm 22 \text{ mA}$ Range $\pm (0 \text{ mA to } 22 \text{ mA})$ $\pm 220 \text{ mA}$ Range $\pm (0 \text{ mA to } 220 \text{ mA})$ $\pm 2.2 \text{ A}$ Range $\pm (0 \text{ A to } 2.2 \text{ A})$	$60 \mu\text{A/A} + 10 \text{ nA}$ $60 \mu\text{A/A} + 10 \text{ nA}$ $60 \mu\text{A/A} + 0.1 \mu\text{A}$ $70 \mu\text{A/A} + 1 \mu\text{A}$ $95 \mu\text{A/A} + 30 \mu\text{A}$	Fluke 5700A
	$\pm 3.2 \text{ A}$ Range $\pm (0.32 \text{ A to } 3.2 \text{ A})$ $\pm 10.5 \text{ A}$ Range $\pm (3.2 \text{ A to } 10.5 \text{ A})$ $\pm 20 \text{ A}$ Range $\pm (10.5 \text{ A to } 20 \text{ A})$	$0.6 \text{ mA/A} + 0.12 \text{ mA}$ $0.55 \text{ mA/A} + 0.94 \text{ mA}$ $0.55 \text{ mA/A} + 4.5 \text{ mA}$	Wavetek 9100
AC CURRENT	$9 \mu\text{A to } 2.2 \text{ A}$ (See Matrix B)	(See Matrix B)	Fluke 5700A
	<u>20 A to 100 A</u> 10 Hz to 1 kHz 1 kHz to 10 kHz	$2.5 \text{ mA/A} + 0.03 \text{ A}$ $5 \text{ mA/A} + 0.05 \text{ A}$	California Instruments CA 3213K

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1. Measuring Instrument Continue AC CURRENT	<u>0.32 A to 3.2 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz <u>3.2 A to 10.5 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz <u>10.5 A to 20 A</u> 10 Hz to 3 kHz 3 kHz to 10 kHz	1 mA/A + 0.48 mA 2.5 mA/A + 2.6 mA 2 mA/A + 3 mA 5 mA/A + 10 mA 2 mA/A + 6.9 mA 5 mA/A + 23 mA	Wavetek 9100
Residual Current	3 mA to 3A At Time interval up to 5 s At Time interval <190 ms	0.14 mA/A 0.3 mA/A	For RCD Tester Calibrator (using Transmille 3200)
CAPACITANCE	(See Matrix C)	(See Matrix C)	Wavetek 9100
Fixed Value	<u>20 Hz to 1 MHz</u> 1 pF, 10 pF, 100 pF, 1000 pF, 0.02 μ F, 0.1 μ F and 1.0 μ F	1 mF/F	HP 1600A series
INDUCTANCE Fixed Value	<u>100 μH @ 1 kHz</u> <u>(1, 10, 100) mH @ 1 kHz</u> <u>1H @ 1 kHz</u>	2.5 mH/H 1 mH/H 1 mH/H	Ando RS-100 series
POWER/ ENERGY (DC)	1 kW to 20 kW 0.1 W to 1 kW	0.7 mW/W 0.22 mW/W	Fluke 5520A
POWER/ ENERGY (AC), (45 Hz to 65 Hz at PF=1)	10 kW to 20 kW 1 W to 10 kW 0.1 W to 1 W	1 mW/W 0.9 mW/W 1 mW/W	

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Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue RESISTANCE Fixed Value	1 m Ω 10 m Ω 100 m Ω 1 Ω 1.9 Ω 10 Ω 19 Ω 100 Ω 190 Ω 1 k Ω 1.9 k Ω 10 k Ω 19 k Ω 100 k Ω 190 k Ω 1 M Ω 1.9 M Ω 10 M Ω 19 M Ω	0.2 m Ω/Ω 0.1 m Ω/Ω 0.02 m Ω/Ω 5 $\mu\Omega/\Omega$ 0.11 m Ω/Ω 5 $\mu\Omega/\Omega$ 31 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 0.02 m Ω/Ω 5 $\mu\Omega/\Omega$ 15 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 14 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 15 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 24 $\mu\Omega/\Omega$ 5 $\mu\Omega/\Omega$ 0.05 m Ω/Ω	Fluke 5700A & Fluke 742A Series
	100 M Ω 1 G Ω 10 G Ω 100 G Ω 1 T Ω	0.13 m Ω/Ω 5 $\mu\Omega/\Omega$ 0.02 Ω/Ω 0.05 Ω/Ω 0.05 Ω/Ω	Fluke 5700A & Takeda Riken TR45
TIME	1 s to 24 Hrs	0.06 $\mu\text{s/s}$ + 0.021 s	Agilent 33250A & Universal Counter HP 53132A
	20 ms to 5 s	0.7 ms	For RCD Tester Calibrator (using Transmille 3200)
Residual Current Duration	10 ms to 5 s	0.4 ms	

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue RPM Measuring Instruments (Non Contact)	60 to 5999 rpm 6000 to 29999 rpm 30000 to 59999 rpm 60000 to 99999 rpm	0.07 rpm 7 rpm 36 rpm 70 rpm	In-House method, ESF/0303
HIGH VOLTAGE METER DC Voltage AC Voltage @ (50/60) Hz	0.5 kV to 10 kV	5 mV/V	TDV 20 ADS & TOS 5101
		8 mV/V	
CLAMP METER DC Current 10 – Turn Coil	± 3.2 A to 32 A ± 32 A to 105 A ± 105 A to 200 A	0.06 mA/A + 1.18 mA 0.55 mA/A + 9.4 mA 0.55 mA/A + 45 mA	Wavetek 9100 c/w Current Coil
50 – Turn Coil	± 16 A to 160 A ± 160 A to 525 A ± 525 A to 1000 A	0.6 mA/A + 5.9 mA 0.55 mA/A + 47 mA 0.55 mA/A + 0.23 A	
AC Current <u>10 – Turn Coil</u>	<u>3.2 A to 32 A</u> 10 Hz to 100 Hz 100 Hz to 440 Hz	2 mA/A + 5.5 mA 7.8 mA/A + 27 mA	
	<u>32 A to 200 A</u> 10 Hz to 100 Hz 100 Hz to 440 Hz	2.1 mA/A + 90 mA 6.7 mA/A + 0.25 A	
CLAMP METER <u>50 – Turn Coil</u>	<u>16 A to 160 A</u> 10 Hz to 100 Hz	2 mA/A + 28 mA	
	<u>160 A to 1000 A</u> 10 Hz to 100 Hz	2.1 mA/A + 0.45 A	

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Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue INSULATION TESTER	(1 k Ω to 10 k Ω) @ 10 V	0.5 m Ω / Ω	Tinsley 4720
	(10 k Ω to 100 k Ω) @ 50 V		
	(0.1 M Ω to 1 M Ω) @ 150 V	1 m Ω / Ω	
	(1 M Ω to 10 M Ω) @ 300 V	10 m Ω / Ω	
	(10 M Ω to 100 M Ω) @ 500 V	50 m Ω / Ω	
	(0.1 G Ω to 1 G Ω) @ 1 kV	0.1 Ω / Ω	
	(1 G Ω to 10 G Ω) @ 5 kV	50 m Ω / Ω	
	(10 G Ω to 100 G Ω) @ 5 kV		
	(100 G Ω to 600 G Ω) @ 5 kV		
OSCILLOSCOPE Vertical Deflection DC Signal	0 V to $\pm$ 6.6 V (50 Ω Load) 0 V to $\pm$ 130 V (1 M Ω Load)	2.5 mV/V + 0.04 mV 0.5 mV/V + 0.04 mV	Fluke 5500A SC600
Vertical Deflection Square Wave Signal	$\pm$ 1 mVp-p to $\pm$ 6.6 Vp-p (50 Ω Load) $\pm$ 1 mVp-p to $\pm$ 130 Vp-p (1 M Ω Load)	2.5 mVp-p/Vp-p + 0.04mVp-p 1 mVp-p/Vp-p + 0.04 mVp-p	
Horizontal Deflection Time Markers (50 Ω Load)	2 ns/div to 20 ms/div 50 ms/div to 5 s/div	2.5 μ s/s (25+(Output x 1000)) μ s/s	
Risetime	$\leq$ 300 ps	+0 ns / -0.1 ns	
Bandwidth Frequency	50 kHz to 600 MHz	2.5 μ Hz/Hz	
	600 MHz to 40 GHz (+11 dBm to -135 dBm)	7 nHz/Hz	
Bandwidth Amplitude	50 kHz to 600 MHz	0.03 Vp-p	Fluke 5500A SC600

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SITE CALIBRATION:

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
1. Measuring Instrument Continue OSCILLOSCOPE Bandwidth Amplitude	600 MHz to 40 GHz (+11 dBm to -135 dBm)	0.92 dBm	Agilent E8257D
Frequency	1 μ Hz to 80 MHz (10 mVpp to 10 Vpp) 10 kHz to 40 GHz (+11 dBm to -135dBm)	36 nHz/Hz 7 nHz/Hz	(Agilent 33250A, ifR2042 or Agilent E8257D) Reference to Pendulum GPS-12R Disciplined by GPS
Amplitude	10 mVp-p to 10 Vp-p (1 μ Hz to 80 MHz, Into 50 Ω)	10 mVpp/Vpp + 1 mVpp	Agilent 33250A
	+13 dBm to -144dBm (10 kHz to 5.4 GHz)	0.58 dBm	ifR2042
	+11 dBm to -135dBm (250 kHz to 40 GHz)	0.92 dBm	Agilent E8257D
Flatness	Sine Wave Relative to 1 kHz (Auto range On)	0.4 dBm	Agilent 33250A

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SITE CALIBRATION:

CATEGORY I

SCOPE OF ACCREDITATION:

Matrix A

AC Voltage Measurement

Range		Frequency			
		Hz		kHz	
		10 to 20	20 to 40	0.04 to 20	20 to 50
2.2 mV	0.22 mV to 2.2 mV	0.6 + 0.005	0.24 + 0.005	0.12 + 0.005	0.41 + 0.005
22 mV	2.2 mV to 22 mV	0.6 + 0.006	0.24 + 0.006	0.12 + 0.006	0.41 + 0.006
220 mV	22 mV to 220 mV	0.6 + 0.016	0.24 + 0.01	0.11 + 0.01	0.36 + 0.01
2.2 V	0.22 V to 2.2 V	0.6 + 0.1	0.18 + 0.03	0.085 + 0.007	0.14 + 0.02
22 V	2.2 V to 22 V	0.6 + 1	0.18 + 0.3	0.085 + 0.07	0.14 + 0.2
220 V	22 V to 220 V	0.6 + 10	0.18 + 3	0.09 + 1	0.25 + 4

Range		Frequency			
		MHz			
		0.05 to 0.1	0.1 to 0.3	0.3 to 0.5	0.5 to 1
2.2 mV	0.22 mV to 2.2 mV	0.95 + 0.008	1.3 + 0.015	1.8 + 0.03	3.6 + 0.03
22 mV	2.2 mV to 22 mV	0.95 + 0.008	1.3 + 0.015	1.8 + 0.03	3.6 + 0.03
220 mV	22 mV to 220 mV	0.9 + 0.03	1.1 + 0.03	1.8 + 0.04	3.6 + 0.1
2.2 V	0.22 V to 2.2 V	0.28 + 0.08	0.48 + 0.15	1.2 + 0.4	2.4 + 1
22 V	2.2 V to 22 V	0.28 + 0.4	0.6 + 1.7	1.4 + 5	3 + 9
220 V	22 V to 220 V	0.6 + 10	1.6 + 110	5.4 + 110	13 + 220

The expanded uncertainties given in this table are expressed in mV/V + mV

Matrix B

AC Current Measurement

Range	Frequency (kHz)				
	0.01 to 0.02	0.02 to 0.04	0.04 to 1	1 to 5	5 to 10
9 μ A to 220 μ A	0.8 + 0.03	0.42 + 0.025	0.16 + 0.02	0.7 + 0.05	1.8 + 0.1
0.22 mA to 2.2 mA	0.8 + 0.05	0.42 + 0.04	0.16 + 0.04	0.7 + 0.5	1.8 + 1
2.2 mA to 22 mA	0.8 + 0.5	0.42 + 0.4	0.16 + 0.4	0.7 + 10	1.8 + 0.01
22 mA to 220 mA	0.8 + 5	0.42 + 4	0.18 + 4	0.7 + 50	1.8 + 100
0.22 A to 2.2 A	-	-	0.75 + 40	0.85 + 100	10 + 200

The expanded uncertainties given in this table are expressed in mA/A + μ A

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SCOPE OF ACCREDITATION:

Matrix C

Capacitance Measurement

Range	Frequency	
	≤ 350 Hz	350 Hz to 1.5 kHz
0.5 nF to 4 nF	3 mF/F + 15 pF	6 mF/F + 0.03 nF
4 nF to 40 nF	3 mF/F + 30 pF	6 mF/F + 0.06 nF
40 nF to 400 nF	3 mF/F + 0.16 nF	6 mF/F + 0.32 nF
400 nF to 4 μ F	4 mF/F + 1.6 nF	8 mF/F + 3.2 nF
4 μ F to 40 μ F	5 mF/F + 16 nF	10 mF/F + 32 nF
40 μ F to 400 μ F	5 mF/F + 0.16 μ F	10 mF/F + 0.32 μ F
400 μ F to 4 mF	5 mF/F + 1.6 μ F	10 mF/F + 3.2 μ F
4 mF to 40 mF	10 mF/F + 0.06 mF	20 mF/F + 0.12 mF

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument DC VOLTAGE	± 100 mV Range $\pm (100 \mu\text{V to } 120 \text{ mV})$	5 $\mu\text{V/V} + 0.3 \mu\text{V}$	HP 3458A Opt. 002
	± 1 V Range $\pm (100 \text{ mV to } 1.2 \text{ V})$	4 $\mu\text{V/V} + 0.3 \mu\text{V}$	
	± 10 V Range $\pm (1 \text{ V to } 12 \text{ V})$	4 $\mu\text{V/V} + 0.5 \mu\text{V}$	
	± 100 V Range $\pm (10 \text{ V to } 120 \text{ V})$	6 $\mu\text{V/V} + 0.03 \text{ mV}$	
	± 1000 V Range $\pm (100 \text{ V to } 1050 \text{ V})$	6 $\mu\text{V/V} + 0.1 \text{ mV}$	
AC VOLTAGE	10 mV to 700V (See Matrix D)	(See Matrix D)	HP 3458A
AC CURRENT	5 μA to 1 A (See Matrix E)	(See Matrix E)	

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue AC CURRENT	1 A to 50 A 50 Hz/ 60 Hz	0.5 mA/A	HP 3458A & Zenith H007098
	50 A to 1000 A 50 Hz/ 60 Hz 40 Hz to 1 kHz	15 mA/A + 2 A 0.03 A/A + 4 A	Kyoritsu 2003
DC CURRENT	$\pm$ (1 nA to 100 nA)	30 μ A/A + 0.04 nA	HP 3458A
	$\pm$ (100 nA to 1 μ A)	20 μ A/A + 0.04 nA	
	$\pm$ (1 μ A to 10 μ A)	20 μ A/A + 0.1 nA	
	$\pm$ (10 μ A to 100 μ A)	20 μ A/A + 0.8 nA	
	$\pm$ (100 μ A to 1 mA)	20 μ A/A + 5 nA	
	$\pm$ (1 mA to 10 mA)	20 μ A/A + 0.05 μ A	
	$\pm$ (10 mA to 100 mA)	35 μ A/A + 0.5 μ A	HP 3458A & Guildline 9211A
	$\pm$ (100 mA to 1 A)	0.11 mA/A + 0.01 mA	
	$\pm$ (1 A to 10 A)	5.1 mA	Kyoritsu 2003
	$\pm$ (10 A to 100 A)	0.05 A	
	$\pm$ (100 A to 1000 A)	15 mA/A + 2A	
CAPACITANCE	1 pF to 1 mF @ (10 Hz to 1 MHz)	0.5 mF/F	HP 4284A
INDUCTANCE	1 μ H to 10 H @ (10 Hz to 1 MHz)	0.5 mH/H	

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue RESISTANCE	0Ω to 10Ω 10Ω to 100Ω $0.1 \text{ k}\Omega$ to $1 \text{ k}\Omega$ $1 \text{ k}\Omega$ to $10 \text{ k}\Omega$ $10 \text{ k}\Omega$ to $100 \text{ k}\Omega$ $0.1 \text{ M}\Omega$ to $1 \text{ M}\Omega$ $1 \text{ M}\Omega$ to $10 \text{ M}\Omega$ $10 \text{ M}\Omega$ to $100 \text{ M}\Omega$ $100 \text{ M}\Omega$ to $1 \text{ G}\Omega$	$15 \mu\Omega/\Omega + 0.05 \text{ m}\Omega$ $12 \mu\Omega/\Omega + 0.05 \text{ m}\Omega$ $10 \mu\Omega/\Omega + 0.05 \text{ m}\Omega$ $10 \mu\Omega/\Omega + 5 \text{ m}\Omega$ $10 \mu\Omega/\Omega + 0.05 \Omega$ $15 \mu\Omega/\Omega + 2 \Omega$ $50 \mu\Omega/\Omega + 0.1 \text{ k}\Omega$ $0.5 \text{ m}\Omega/\Omega + 1 \text{ k}\Omega$ $5 \text{ m}\Omega/\Omega + 0.01 \text{ M}\Omega$	HP 3458A
Signal Genarator FREQUENCY	1 Hz to 5 GHz	0.91 pHz/Hz	HP53132A Reference to Pendulum GPS-12R Manual hold-over
AMPLITUDE/ LEVEL	5 GHz to 27 GHz	0.89 Hz/Hz	HP8563E Reference to Pendulum GPS- 12R Manual hold- over
	-20 dBm to +30 dBm (100 kHz to 2.6 GHz)	0.04 dBm	HP 8902 with 11722A
	-30 dB to +30 dB (2.6 GHz to 18 GHz)	0.27 dBm	Agilent E4418B with HP 8481A
	-120 dB to +30 dB (30 Hz to 27 GHz)	1 dBm	HP8563E
TUNED RF LEVEL	-127 dB to 0 dB (2.5 MHz to 1.3 GHz)	0.07 dBm	HP 8902 with 11722A

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
2. Generating Instrument Continue RPM (Non-Contact Type)	10 to 29 rpm 30 to 59 rpm 60 to 99 rpm 100 to 299 rpm 300 to 599 rpm 600 to 999 rpm 1000 to 2999 rpm 3000 to 5999 rpm 6000 to 9999 rpm 10000 to 29999 rpm 30000 to 59999 rpm 60000 to 99999 rpm	0.014 rpm 0.036 rpm 0.07 rpm 0.14 rpm 0.37 rpm 0.7 rpm 1.4 rpm 3.6 rpm 7 rpm 14 rpm 36 rpm 70 rpm	In-House method, ESF/0303.
RPM (Contact Type)	20 to 29 rpm 30 to 59 rpm 60 to 99 rpm 100 to 299 rpm 300 to 599 rpm 600 to 999 rpm 1000 to 2999 rpm 3000 to 5999 rpm 6000 to 9999 rpm 10000 to 12999 rpm 13000 to 25999 rpm 26000 to 29999 rpm	0.011 rpm 0.016 rpm 0.029 rpm 0.07 rpm 0.16 rpm 0.29 rpm 0.7 rpm 1.6 rpm 2.9 rpm 7 rpm 8 rpm 14 rpm	
High Voltage Tester DC VOLTAGE	0 kV to 9.9 kV 10 kV to <20 kV 20 kV to 35 kV >35 kV to 40 kV	5 mV/V + 2 V 20 mV/V 10 mV/V 20 mV/V	TDV 20 ADS Fluke 80K-40
AC VOLTAGE	(0 kV to 9.99 kV) @ 50/60Hz (10 kV to 20 kV) @ 50/60 Hz (20 kV to 28 kV) @ 50/60 Hz	7 mV/V + 3 V 7 mV/V + 30 V 50 mV/V	

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SCOPE OF ACCREDITATION:

Matrix D

AC Voltage Generation (HP 3458A)

Range		Frequency Band				
		1 to 40 Hz	0.1 to 1 MHz	1 to 4 MHz	4 to 8 MHz	8 to 10 MHz
10 mV	1 to 12 mV	0.3 + 3	12 + 5	70 + 7	0.2 V/V + 8	–

Range		Frequency Band				
		1 to 40 Hz	1 to 2 MHz	2 to 4 MHz	4 to 8 MHz	8 to 10 MHz
100 mV	10 to 120 mV	70 μ V/V + 4	15 + 10	40 + 70	40 + 80	0.15 V/V + 0.1 mV
1 V	0.1 V 1.2 V	70 μ V/V + 40	15 + 0.1 mV	40 + 0.7 mV	40 + 0.8 mV	0.15 V/V + 1 mV
10 V	1 to 12 V	70 μ V/V + 0.4 mV	15 + 1 mV	40 + 7 mV	40 + 8 mV	0.15 V/V + 10 mV

Range		Frequency Band	
		1 to 40 Hz	0.3 to 1 MHz
100 V	10 to 120 V	0.2 + 4 mV	15 + 10 mV
1000 V	100 to 700 V	0.4 + 40 mV	

The expanded uncertainties given in this table are expressed in mV/V + μ V unless otherwise stated.

Matrix E

AC Current Generation (HP 3458A)

Range		Frequency Band			
		10 to 20 Hz	20 to 45 Hz	45 to 100 Hz	100 Hz to 5 kHz
100 μ A	5 to 120 μ A	4 + 30 nA	1.5 + 30 nA	0.6 + 3 nA	
1 mA	0.05 to 1.2 mA	4 + 0.2	1.5 + 0.2	0.6 + 0.2	0.3 + 0.2
10 mA	0.5 to 12 mA	4 + 2	1.5 + 2	0.6 + 2	0.3 + 2
100 mA	5 to 120 mA	4 + 20	1.5 + 20	0.6 + 20	0.3 + 20
1 A	0.05 to 1.05 A	4 + 0.2 mA	1.6 + 0.2 mA	0.8 + 0.2 mA	1 + 0.2 mA

Range		Frequency Band		
		5 to 20 kHz	20 to 50 kHz	50 to 100 kHz
1 mA	0.05 to 1.2 mA	0.6 + 0.2	4 + 0.4	5.5 + 1.5
10 mA	0.5 to 12 mA	0.6 + 2	4 + 4	5.5 + 15
100 mA	5 to 120 mA	0.6 + 20	4 + 40	5.5 + 0.15 mA
1 A	0.05 to 1.05 A	3 + 0.2 mA	10 + 0.4 mA	

The expanded uncertainties given in this table are expressed in mA/A + μ A unless otherwise stated.

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SCOPE OF ACCREDITATION:

Signatories:

1. **Muhammed Fahimy Bin Ahmad Ta'adin**
2. **Mohamed Fikri Bin Mohd Nor**
3. **Syahrel Bin Shari**

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FIELD OF CALIBRATION: TEMPERATURE

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Liquid In-glass Thermometer (Partial Immersion)	0 °C to 200 °C	2 °C	Comparison method using SPRT & PRT
Liquid-in-glass thermometer (Total Immersion)	- 80 °C to 0 °C 0 °C to 80 °C 80 °C to 250 °C 250 °C to 500 °C	0.05 °C 0.03 °C 0.05 °C 0.10 °C	Comparison method using SPRT & PRT
Platinum Resistance Thermometer	- 80 °C to 250 °C 250 °C to 600 °C 600 °C to 950 °C	0.05 °C 0.1 °C 0.5 °C	Comparison method using SPRT & PRT
Thermocouple	- 80 °C to 250 °C 250 °C to 950 °C	0.5 °C 0.6 °C	Comparison method using SPRT, PRT and Standard Thermocouple Type R
Psychrometer Thermohygrograph Thermohygrometer	10 °C to 50 °C 35 % to 95 %RH	0.5 °C 3.0 %RH	Comparison Method Using Wet and Dry bulb base on BS 1339-1 2002
Temperature switch	- 50 °C to 10 °C 10 °C to 100 °C 100 °C to 600 °C	1 °C 2 °C 3 °C	Comparison method using SPRT, PRT and Thermocouple Type R
Mechanical thermometer	- 80 °C to 50 °C 50 °C to 600 °C	0.1 °C 1.5 °C	Comparison method using SPRT, PRT and Thermocouple Type R
Temperature Calibrator (Dry block)	- 30 °C to 400 °C 400 °C to 950 °C	0.1 °C 1.2 °C	EA-10 /13 (EAL Guideline for calibration of Dry block Calibrator)

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Temperature Indicating Instruments			
K - type	- 200 °C to 0 °C 0 °C to 1300 °C	0.4 °C 0.4 °C	
J - type	- 200 °C to 0 °C 0 °C to 1100 °C	0.3 °C 0.3 °C	
T - type	- 200 °C to 0 °C 0 °C to 400 °C	0.5 °C 0.4 °C	
E - type	- 200 °C to 0 °C 0 °C to 900 °C	0.4 °C 0.3 °C	
R - type	0 °C to 1000 °C 1000 °C to 1700 °C	1.3 °C 1.1 °C	
S - type	0 °C to 1000 °C 1000 °C to 1700 °C	1.3 °C 1.2 °C	
Pt 100	- 200 °C to 0 °C 0 °C to 800 °C	0.2 °C 0.5 °C	
			Calibration by Electrical simulation using Temperature Calibrator

Signatory:

1. **Zulkifli Ahmad**

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FIELD OF CALIBRATION: TEMPERATURE

SITE CALIBRATION: CATEGORY I

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Humidity Chamber	20 % to 95 %RH	2.0 % of RH	AS 2853-1986 BS 1339-1 :2002
Temperature Controlled Enclosure	- 60 °C to 200 °C 200 °C to 400 °C 400 °C to 950 °C	0.8 °C 1.2 °C 2 °C	AS 2853 -1986
Temperature Indicating Instruments			
K - type	- 200 °C to 0 °C 0 °C to 1300 °C	0.4 °C 0.4 °C	Calibration by Electrical simulation using Temperature Calibrator
J - type	- 200 °C to 0 °C 0 °C to 1100 °C	0.3 °C 0.3 °C	
T - type	- 200 °C to 0 °C 0 °C to 400 °C	0.5 °C 0.4 °C	
E - type	- 200 °C to 0 °C 0 °C to 900 °C	0.4 °C 0.3 °C	
R – type	0 °C to 1000 °C 1000 °C to 1700 °C	1.3 °C 1.1 °C	
S - type	0 °C to 1000 °C 1000 °C to 1700 °C	1.3 °C 1.2 °C	
Pt 100	- 200 °C to 0 °C 0 °C to 800 °C	0.2 °C 0.5 °C	

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Signatory:

1. Zulkifli Ahmad

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SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Temperature Sensor with Indicator -PT100	0 °C to 300 °C	0.15 °C	Calibration by comparison method using:
	301 °C to 600 °C	0.26 °C	
-Thermocouple	0 °C to 300 °C	0.15 °C	1-Pt100 & Type R Thermocouple as reference standards
	301 °C to 600 °C	0.26 °C	
	601 °C to 950 °C	1.1 °C	2-Dry Block Calibrator

Signatory:

1. Zulkifli Ahmad

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FIELD OF CALIBRATION: DIMENSIONAL

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Gauge Block	0.5 mm to 100 mm 100 mm to 250 mm	(0.1 + 1.0 L) μ m L in m	Reference Equipment: Gauge block
Gauge Block (Imperial units)	0.05 inch to 4 inch	(0.004 + 1.0 L) μ inch L in inch	Gauge block
Bevel Protractor	0 to 360 degrees : Graduation 5 min. Graduation 1 deg.	3 minute 0.5 degree	Angle block
Snap Gauge / Caliper Gauge	Up to 200 mm	5 μ m	Uni. Measuring M/c
Micrometer 25 mm travels for frame Sizes 25 mm, 50 mm, 75 mm and 100mm	0.001 mm to 100 mm	2 μ m	Gauge Block
Caliper	0.01 mm to 300 mm 300 mm to 600 mm 600 mm to 1000 mm	7 μ m 9 μ m 12 μ m	Gauge Block Caliper Checker
Height Gauge	0.01 mm to 600 mm	10 μ m	Caliper Checker
Caliper Checker	20 mm to 300 mm 301 mm to 600 mm	3 μ m 6 μ m	Long Gauge block
Calibration Tester	0 mm to 25 mm	2 μ m	Dig.Length Indicator /Gauge Block
Dial / Digital Test Indicator	0.001 mm to 100 mm	2 μ m	Dial gauge testing machine
Dial / Digital Gauge	0.001 mm to 100 mm	2 μ m	Dial gauge testing machine
Dial / Digital Thickness Gauge	0.01 mm to 50 mm	5 μ m	Gauge Block
Depth Micro-Checker	0 mm to 300 mm	6 μ m	Gauge Block / Pre. Height Gauge

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FIELD OF CALIBRATION: DIMENSIONAL

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Feeler Gauge	0.005 mm to 2.0 mm	3 μ m	Dig.Length Indicator
Glass Scale	up to 200 mm 200 mm to 300 mm	3.8 μ m 5.6 μ m	Uni. Measuring M/c
Grind Gauge/Fine Gauge	0.001 mm to 0.15 mm	2 μ m	Dig.Length Indicator
Height master	0.001 mm to 600 mm	6 μ m	Pre. Height Gauge / Gauge Block
Ruler	0.1 mm to 2000 mm	0.1 mm	Linear scale
Mu-checker	0.1 mm to 2000 μ m	2 μ m	Gauge Block
Precision Height Gauge	0.001 mm to 600 mm	4 μ m	Gauge Block
Straight Edge	0 mm to 600 mm	1.5 μ m	Dig.Length Indicator / Straight edge
Tape	0 m to 100 m	(0.33 + 0.019 L) mm <i>L is length in unit meter</i>	Linear scale
Thickness Foil	0.001 mm to 2.0 mm	3 μ m	Dig.Length Indicator
Setting/Standard Rod	25 mm to 100 mm 100 mm to 600 mm	(0.15 + 0.0064 L) (0.11 + 0.008 L) <i>L is length in unit mm</i>	Universal Length Machine and Gauge Block
Plain Pin or Plug Gauge (Diameter Only)	0.2 mm to 50 mm	0.5 μ m	Universal Length Machine
Plain Ring Gauge (Diameter Only)	1 mm to 100 mm 100 mm to 200 mm	(0.007 L + 0.11) μ m (0.0064 L + 0.41) μ m <i>L is diameter in unit mm</i>	Universal Length Machine and Gauge Block
Thread Plug Gauge (Simple Pitch Diameter)	2 mm to 50 mm	2 μ m	Universal Length Machine (In-house Method)
Length Machine (For in-house equipment only)	0 mm to 1 m 0 mm to 10 m	0.1 mm 0.4 mm	Standard Scale

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FIELD OF CALIBRATION: **DIMENSIONAL**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Universal Measuring Microscope (Individual linear axis only- <i>For in-house equipment only</i>)	0 mm to 200 mm	2.5 μ m	Standard Scale
Digital Length Indicator	0 to 25 mm	0.4 μ m	Gauge Block

Signatories:

1. **Hasnah Bt Hassan**
2. **Mohd Hashim Effandi**
3. **Mohd Amri Abd Aziz**
4. **Dr. Wan Abd Malik Wan Mohamed**

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FIELD OF CALIBRATION: **DIMENSIONAL**

SITE CALIBRATION: **CATEGORY I**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Profile Projector (X or Y axis only)	1 mm to 200 mm	5 μ m	Glass Scale
	201 mm to 300 mm	7 μ m	
Surface Table/Plate	2500 mm x 1600 mm	3 μ m/m	Levelnic / Plankator

Signatories:

1. **Hasnah Bt Hassan**
2. **Mohd Hashim Effandi**
3. **Mohd Amri Abd Aziz**
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FIELD OF CALIBRATION: MASS

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Standard Weights Class E2 , F1, F2, M1, M2 & M3	1 mg 2 mg 5 mg 10 mg 20 mg 50 mg 100 mg 200 mg 500 mg 1 g 2 g 5 g 10 g 20 g 50 g 100 g 200 g 500 g 1 kg 2 kg 5 kg 10 kg 20 kg 50 kg	0.002 mg 0.002 mg 0.002 mg 0.002 mg 0.003 mg 0.004 mg 0.005 mg 0.006 mg 0.008 mg 0.010 mg 0.012 mg 0.016 mg 0.020 mg 0.025 mg 0.03 mg 0.05 mg 0.10 mg 0.23 mg 0.5 mg 1.0 mg 3.0 mg 16 mg 32 mg 78 mg	With general reference to OIML R111. Mass comparison using: ABBA weighing scheme for weights of OIML classes E2 and F1; and AB, AB weighing scheme for weights of OIML classes F2 and below
Weight Blocks	1 mg to 10 g Above 10 g to 50 g Above 50 g to 100 g Above 100 g to 200 g Above 200 g to 500 g Above 500 g to 1 kg Above 1 kg to 2 kg Above 2 kg to 5 kg Above 5 kg to 10 kg Above 10 kg to 20 kg Above 20 kg to 30 kg Above 30 kg to 60 kg Above 60 kg to 100 kg Above 100 kg to 200 kg Above 200 kg to 500 kg	2 mg 3 mg 5 mg 9 mg 0.02 g 0.05 g 0.09 g 0.2 g 0.5 g 0.9 g 1.3 g 2.6 g 0.02 kg 0.02 kg 0.04 kg	Mass comparison using AB, AB weighing scheme

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FIELD OF CALIBRATION: **MASS**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Spring /Hanging Scale	up to 5 kg up to 20 kg up to 50 kg up to 100 kg	16 g 31 g 62 g 0.13 kg	Using calibrated standard weights of OIML classes F1

Signatories:

1. **Mohammad Najib Kamaruddin**
2. **Dr. Wan Abd Malik Wan Mohamed**

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FIELD OF CALIBRATION: **MASS**

SITE CALIBRATION: **CATEGORY I**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Analytical Balance	up to 50 g up to 100 g up to 200 g	0.13 mg 0.15 mg 0.2 mg	OIML class E2 Reference Weights
Balance / Scale (Triple Beam, Single Beam Spring, Top Pan, Mechanical & Electronic)	up to 1000 g up to 2000 g up to 5000 g up to 10000 g up to 20 kg up to 50 kg up to 100 kg up to 200 kg up to 500 kg	2 mg 0.02 g 0.02 g 0.2 g 0.2 g 2 g 13 g 0.03 kg 0.1 kg	OIML classes F1/F2/M2 Reference Weights
Electrical and Mechanical Platform Balance	up to 1000 kg up to 2000 kg	0.27 kg 0.66 kg	OIML class M2 Reference Weights

Signatories:

1. **Mohammad Najib Kamaruddin**
2. **Dr. Wan Abd Malik Wan Mohamed**

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FIELDS OF CALIBRATION: FORCE & TORQUE

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
FORCE MEASUREMENT			ISO 376 : 2004
Proving Rings/Load Cells	0 kgf to 100 kgf 101 kgf to 500 kgf 501 kgf to 1000 kgf 1001 kgf to 5000 kgf 5001 kgf to 10000 kgf 10001 kgf to 30000 kgf	0.04 kgf 0.2 kgf 0.3 kgf 3 kgf 26 kgf 108 kgf	LC 100 kgf LC 500 kgf LC 1000 kgf LC 5000 kgf LC 10000 kgf LC 45000 kgf
Push-pull/ Force Gauge	1 gf to 5 kgf 5 kgf to 20 kgf 20 kgf to 50 kgf 50 kgf to 100 kgf	16 gf 31 gf 62 gf 124 gf	ASTM E74-95 Reference F1 & F2
Gramme/ Dial Tension Gauge	1 gf to 50 gf 50 gf to 500 gf 500 gf to 2000 gf	1 gf 6 gf 30 gf	ASTM E74-95 Reference F1 & F2
TORQUE MEASUREMENT			
Torque wrench	0 N.m to 2 N.m 2.1 N.m to 10 N.m 11 N.m to 100 N.m 101 N.m to 500 N.m	0.07 N.m 0.1 N.m 0.3 N.m 2 N.m	Comparison with torque transducers with general reference to BS EN ISO 6789 : 2003 Transducer 2 N.m Transducer 100 N.m Transducer 1000 N.m 10 N.m Torque Meter
Torque meter and analyser	0 N.m to 2 N.m 3 N.m to 50 N.m 51 N.m to 100 N.m 101 N.m to 500 N.m	0.1% of reading 0.1% of reading 0.1% of reading 0.1% of reading	With general reference to BS 7882 : 2008

Note: LC (Load Cell)

Signatories:

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FIELD OF CALIBRATION: FORCE

SITE CALIBRATION: CATEGORY I

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Universal Testing Machine / Compression mode (tension mode up to 5000 kgf)	0 kgf to 100 kgf 101 kgf to 500 kgf 501 kgf to 1000 kgf 1001 kgf to 5000 kgf 5001 kgf to 10000 kgf 10001 kgf to 60000 kgf 60001 kgf to 200000 kgf	0.04 kgf 0.2 kgf 0.3 kgf 3 kgf 26 kgf 378 kgf 460 kgf	Comparison with load cell based on BS EN ISO 7500- 1:2004 LC 100 kgf LC 500 kgf LC 1000 kgf LC 5000 kgf LC 10000 kgf LC 90000 kgf LC 200000 kg
Charpy / Izod Impact Tester	1 Joule to 300 Joules	1 % of reading	BS 131-7 : 1998

Note: LC (Load Cell)

Signatories:

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FIELD OF CALIBRATION: PRESSURE

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Pressure measuring device (Gas medium)	1 psi to 100 psi 101 psi to 1600 psi	0.02 % of pressure 0.02 % of pressure	Comparison with Dead Weight Tester based on BS EN 837-1, 837-2, 837-3 ADWT ADWT
Pressure measuring device (Oil and water medium)	10 psi to 800 psi 801 psi to 16000 psi	0.02 % of pressure 0.02 % of pressure	DWT DWT
	16 0001 psi to 40000 psi	0.02 % of pressure	Based on BS EN 837-1 BS EN 837-2 BS EN 837-3
Vacuum gauge	Ambient to 67 cm Hg	0.1 % of pressure	Mercury Manometer
Low Pressure Measuring Devices Mercury Manometer	0 to 1500 mm Hg	0.02 % of pressure	Digital Manometer Reference Pressure Balance
Deadweight Tester	10 psi to 40 000 psi	0.02 % of pressure	Cross float method OIML R110 1994(E) NCSL RISP-4 2000 EAL G26/EA-4/17 JULY 1997 Pressure Balance

Note: ADWT (Air Dead Weight Tester)
DWT (Dead Weight Tester)

Signatories:

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FIELD OF CALIBRATION: PRESSURE

SITE CALIBRATION: CATEGORY I

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Pressure measuring device (Oil medium)	0 psi to 500 psi 0 psi to 1000 psi 0 psi to 3000 psi 0 psi to 4500 psi 0 psi to 7500 psi 0 psi to 10 000 psi 0 psi to 12 000 psi 0 psi to 16 000 psi	0.7 % of pressure 0.7 % of pressure 0.6 % of pressure 0.4 % of pressure 0.4 % of pressure 0.7 % of pressure 0.6 % of pressure 0.6 % of pressure	BS EN 837-1 BS EN 837-2 BS EN 837-3 Pressure Balance
Vacuum Measuring Devices	Ambient to -70 cm Hg	1.0 % of pressure	Pressure Calibrator
Pressure Gauge	0 bar to 20 bar	0.5 % of pressure	Pressure Calibrator

Signatories:

1. Noor Azam Ismail
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FIELD OF CALIBRATION: VOLUMETRIC

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Bulb Pipette	1 ml to 5 ml 5 ml to 100 ml	0.008 ml 0.03 ml	Cal .Procedure No TCP 0002 REV2.0 Ref: ISO 4787
Graduated Pipette	1 ml to 5 ml 5 ml to 100 ml	0.008 ml 0.03 ml	Cal .Procedure No TCP 0002 REV2.0 Ref: ISO 4787
Measuring Cylinder	5 ml to 100 ml 100 ml to 500 ml 500 ml to 1000 ml 1000 ml to 2000 ml	0.05 ml 0.5 ml 2.0 ml 3.0 ml	Cal .Procedure No TCP 0001 REV2.0 Ref: ISO 4787
Burette	1 ml to 50 ml	0.05 ml	Cal .Procedure No TCP 0003 REV2.0 Ref: ISO 4787
Beaker & Flasks	5 ml to 100 ml 100 ml to 1000 ml 1000 ml to 2000 ml	1.0 ml 3.0 ml 5.0 ml	Cal .Procedure No TCP 0004 REV2.0 Ref: ISO 4787
Piston-operated Volumetric apparatus	10 μ l to 20 μ l 20 μ l to 50 μ l 50 μ l to 100 μ l 100 μ l to 200 μ l 200 μ l to 500 μ l 500 μ l to 1000 μ l 1000 μ l to 5000 μ l 5000 μ l to 10000 μ l 10000 μ l	0.03 μ l 0.09 μ l 0.15 μ l 0.4 μ l 0.8 μ l 1.8 μ l 3.5 μ l 20 μ l 40 μ l	No.TCP/0005 REV.0.0 Based on ISO 8655- 6:2002

The valid scope of accreditation is in www.ism.gov.my/cab-directories.

Signatories:

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FIELD OF CALIBRATION: **HYDROMETER**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Density Hydrometer	0.600 g/ml to 0.650 g/ml 0.650 g/ml to 0.700 g/ml 0.700 g/ml to 0.750 g/ml 0.750 g/ml to 0.800 g/ml 0.800 g/ml to 0.850 g/ml 0.850 g/ml to 0.900 g/ml 0.900 g/ml to 0.950 g/ml 0.950 g/ml to 1.000 g/ml 1.000 g/ml to 1.050 g/ml 1.050 g/ml to 1.100 g/ml 1.100 g/ml to 1.150 g/ml 1.150 g/ml to 1.200 g/ml 1.200 g/ml to 1.250 g/ml 1.250 g/ml to 1.300 g/ml 1.300 g/ml to 1.350 g/ml 1.350 g/ml to 1.400 g/ml 1.400 g/ml to 1.450 g/ml 1.450 g/ml to 1.500 g/ml	0.001 g/ml (resolution 0.0005 g/ml)	Comparison Method BS 718:1991

Signatories:

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FIELD OF CALIBRATION: **HYDROMETER**

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Temperature 1. Specific Gravity Hydrometer	0.6 to 0.65 0.65 to 0.7 0.7 to 0.75 0.75 to 0.8 0.8 to 0.85 0.85 to 0.9 0.9 to 0.95 0.95 to 1 1 to 1.1 1.1 to 1.2 1.2 to 1.3 1.3 to 1.4 1.4 to 1.5	0.001 (resolution 0.0005)	Cal. Procedure No. MDL 0002 Rev.1.0 Reference: BS 718:1991

Signatories:

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FIELD OF CALIBRATION: OPTICAL & PHOTOMETRY

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Measuring Instrument			
Smoke Meter	32% to 35%	0.23%	Technometer calibrated filter set
Opacity	26% to 59%	0.13%	
	77% to 80%	0.22%	
(Technometer 800 SERIES models)			

Signatories:

1. Dr. Wan Abd Malik Wan Mohamed
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FIELD OF CALIBRATION: OPTICAL & PHOTOMETRY

SITE CALIBRATION: CATEGORY I

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Measuring Instrument Smoke Meter Opacity (Technometer 800 SERIES models)	32% to 35% 26% to 59% 77% to 80%	0.23% 0.13% 0.22%	Technometer calibrated filter set

Signatories:

1. Dr. Wan Abd Malik Wan Mohamed
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FIELD OF CALIBRATION: ACOUSTIC & VIBRATION

SCOPE OF ACCREDITATION:

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Measuring Instrument Sound Level Meter	Nominal SPL 94 dB, 104 dB & 114 dB Reference 94 dB re 20 μ Pa at 1 kHz 31.5 Hz to 1600 Hz 124 dB (at 250Hz) (54 to 134) dB (31.5 to 12500) Hz	 0.11 dB 0.21 dB 0.13 dB	 Generating using Briel & Kjaer 4226 Generating using Briel & Kjaer 4228 Electrical Signal Injection from signal operator Agilent 33220A
Sourcing/Generating Instrument Sound Calibrator	Nominal SPL 94dB, 104 dB & 114 dB Reference 94 dB re 20 μ Pa at 1 kHz 31.5 Hz to 1600 Hz 124 dB (at 250Hz)	 0.11 dB 0.21 dB	 Comparison with reference Calibrator Briel & Kjaer 4226 and Agilent 34401A Comparison with reference Calibrator Briel & Kjaer 4228 and Agilent 34401A

The valid scope of accreditation is in www.ism.gov.my/cab-directories.

Signatories:

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3. Syahrel Bin Shari

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FIELD OF CALIBRATION: ACOUSTIC & VIBRATION

SCOPE OF ACCREDITATION: CATEGORY I

Instrument Calibrated/ Measurement Parameter	Range	Calibration and Measurement Capability Expressed as an Uncertainty ($\pm$)*	Remarks
Measuring Instrument Sound Level Meter	Nominal SPL 94 dB, 104 dB & 114 dB Reference 94 dB re 20 μ Pa at 1 kHz 31.5 Hz to 1600 Hz 124 dB (at 250Hz) (54 to 134) dB (31.5 to 12500) Hz	 0.11 dB 0.21 dB 0.13 dB	Generating using Briel & Kjaer 4226 Generating using Briel & Kjaer 4228 Electrical Signal Injection from signal operator Agilent 33220A
Sourcing/Generating Instrument Sound Calibrator	Nominal SPL 94dB, 104 dB & 114 dB Reference 94 dB re 20 μ Pa at 1 kHz 31.5 Hz to 1600 Hz 124 dB (at 250Hz)	 0.11 dB 0.21 dB	Comparison with reference Calibrator Briel & Kjaer 4226 and Agilent 34401A Comparison with reference Calibrator Briel & Kjaer 4228 and Agilent 34401A

The valid scope of accreditation is in www.ism.gov.my/cab-directories.

Signatories:

1. Dr. Wan Abd Malik Wan Mohamed
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